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With the principle of "Quality Parts,Customers Priority,Honest Operation, and Considerate Service",our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip,ALPS,ROHM,Xilinx,Pulse,ON,Everlight and Freescale. Main products comprise IC,Modules,Potentiometer,IC Socket,Relay,Connector.Our parts cover such applications as commercial,industrial, and automotives areas.

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## APT50GT120B2R（G） APT50GT120LR（G）

$1200 \mathrm{~V}, 50 \mathrm{~A}, \mathrm{~V}_{\mathrm{CE}(\mathrm{ON})}=3.2 \mathrm{~V}$ Typical

## Thunderbolt IGBT ${ }^{\circledR}$

The Thunderbolt IGBT ${ }^{\circledR}$ is a new generation of high voltage power IGBTs．Using Non－Punch－Through Technology，the Thunderbolt IGBT ${ }^{\circledR}$ offers superior rugged－ ness and ultrafast switching speed．

## Features

－Low Forward Voltage Drop
－Low Tail Current
－RoHS Compliant
－RBSOA and SCSOA Rated
－High Frequency Switching to 50 KHz
－Ultra Low Leakage Current


Unless stated otherwise，Microsemi discrete IGBTs contain a single IGBT die．This device is made with two parallel IGBT die．It is intended for switch－mode operation．It is not suitable for linear mode operation．

## Maximum Ratings

| Symbol | Parameter | Ratings | Unit |
| :---: | :--- | :---: | :---: |
| $\mathrm{V}_{\mathrm{CES}}$ | Collector－Emitter Voltage | 1200 | Volts |
| $\mathrm{V}_{G E}$ | Gate－Emitter Voltage | $\pm 30$ |  |
| $\mathrm{I}_{\mathrm{C} 1}$ | Continuous Collector Current $@ \mathrm{~T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ | 94 |  |
| $\mathrm{I}_{\mathrm{C} 2}$ | Continuous Collector Current＠ $\mathrm{T}_{\mathrm{C}}=100^{\circ} \mathrm{C}$ | 50 | Amps |
| $\mathrm{I}_{\mathrm{CM}}$ | Pulsed Collector Current ${ }^{(1)}$ | 150 |  |
| SSOA | Switching Safe Operating Area $@ \mathrm{~T}_{J}=150^{\circ} \mathrm{C}$ | $150 \mathrm{~A} @ 1200 \mathrm{~V}$ |  |
| $\mathrm{P}_{\mathrm{D}}$ | Total Power Dissipation | 625 | Watts |
| $\mathrm{T}_{J,} \mathrm{~T}_{\text {STG }}$ | Operating and Storage Junction Temperature Range | -55 to 150 | C |
| $\mathrm{T}_{\mathrm{L}}$ | Max．Lead Temp．for Soldering： $0.063^{\prime \prime}$ from Case for 10 Sec． | 300 |  |


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All Ratings： $\mathrm{T}_{\mathrm{C}}=25^{\circ} \mathrm{C}$ unless otherwise specified．

## Static Electrical Characteristics

| Symbol | Characteristic／Test Conditions | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\text {（BR）CES }}$ | Collector－Emitter Breakdown Voltage（ $\left.\mathrm{V}_{\mathrm{GE}}=0 \mathrm{~V}, \mathrm{I}_{\mathrm{C}}=3 \mathrm{~mA}\right)$ | 1200 | － | － | Volts |
| $\mathrm{V}_{\text {GE（TH）}}$ | Gate Threshold Voltage（ $\left.\mathrm{V}_{\mathrm{CE}}=\mathrm{V}_{\mathrm{GE}}, \mathrm{I}_{\mathrm{C}}=2 \mathrm{~mA}, \mathrm{~T}_{\mathrm{j}}=25^{\circ} \mathrm{C}\right)$ | 4.5 | 5.5 | 6.5 |  |
| $\mathrm{V}_{\text {CE（ON）}}$ | Collector Emitter On Voltage（ $\left.\mathrm{V}_{\mathrm{GE}}=15 \mathrm{~V}, \mathrm{I}_{\mathrm{C}}=50 \mathrm{~A}, \mathrm{~T}_{\mathrm{j}}=25^{\circ} \mathrm{C}\right)$ | 2.7 | 3.2 | 3.7 |  |
|  | Collector Emitter On Voltage（ $\left.\mathrm{V}_{\mathrm{GE}}=15 \mathrm{~V}, \mathrm{I}_{\mathrm{C}}=50 \mathrm{~A}, \mathrm{~T}_{\mathrm{j}}=125^{\circ} \mathrm{C}\right)$ | － | 4.0 | － |  |
| $I_{\text {ces }}$ | Collector Cut－off Current（ $\left.\mathrm{V}_{\mathrm{CE}}=1200 \mathrm{~V}, \mathrm{~V}_{\mathrm{GE}}=0 \mathrm{~V}, \mathrm{~T}_{\mathrm{j}}=25^{\circ} \mathrm{C}\right)^{2}{ }^{2}$ | － | － | 200 | $\mu \mathrm{A}$ |
|  | Collector Cut－off Current（ $\left.\mathrm{V}_{\mathrm{CE}}=1200 \mathrm{~V}, \mathrm{~V}_{\mathrm{GE}}=0 \mathrm{~V}, \mathrm{~T}_{\mathrm{j}}=125^{\circ} \mathrm{C}\right)^{(2)}$ | － | － | 2.0 | mA |
| $\mathrm{I}_{\text {GES }}$ | Gate－Emitter Leakage Current（ $\mathrm{V}_{\mathrm{GE}}= \pm 20 \mathrm{~V}$ ） | － | － | 300 | nA |

[^0]Dynamic Characteristics
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| Symbol | Characteristic | Test Conditions | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{C}_{\text {ies }}$ | Input Capacitance | $\begin{gathered} V_{G E}=0 V, V_{C E}=25 \mathrm{~V} \\ f=1 \mathrm{MHz} \end{gathered}$ | - | 3300 | - | pF |
| $\mathrm{C}_{\text {oes }}$ | Output Capacitance |  | - | 500 | - |  |
| $\mathrm{C}_{\text {res }}$ | Reverse Transfer Capacitance |  | - | 220 | - |  |
| $V_{\text {GEP }}$ | Gate-to-Emitter Plateau Voltage | Gate Charge$\begin{gathered} V_{G E}=15 \mathrm{~V} \\ V_{C E}=600 \mathrm{~V} \\ \mathrm{I}_{\mathrm{C}}=50 \mathrm{~A} \end{gathered}$ | - | 10.5 | - | V |
| $\mathrm{Q}_{\mathrm{g}}$ | Total Gate Charge |  | - | 340 | - | nC |
| $\mathrm{Q}_{\mathrm{ge}}$ | Gate-Emitter Charge |  | - | 40 | - |  |
| $\mathrm{Q}_{\mathrm{gc}}$ | Gate-Collector Charge |  | - | 210 | - |  |
| SSOA | Switching Safe Operating Area | $\begin{gathered} \mathrm{T}_{\mathrm{J}}=150^{\circ} \mathrm{C}, \mathrm{R}_{\mathrm{G}}=1.0 \Omega^{\odot}, \mathrm{V}_{\mathrm{GE}}=15 \mathrm{~V}, \\ \mathrm{~L}=100 \mu \mathrm{H}, \mathrm{~V}_{\mathrm{CE}}=1200 \mathrm{~V} \end{gathered}$ | 150 |  |  | A |
| $\mathrm{t}_{\mathrm{d}(\mathrm{on})}$ | Turn-On Delay Time | Inductive Switching ( $25^{\circ} \mathrm{C}$ ) | - | 24 | - | ns |
| $\mathrm{t}_{\mathrm{r}}$ | Current Rise Time |  | - | 53 | - |  |
| $\mathrm{t}_{\text {d(off) }}$ | Turn-Off Delay Time | $\begin{aligned} \mathrm{V}_{\mathrm{CC}} & =800 \mathrm{~V} \\ \mathrm{~V}_{\mathrm{GE}} & =15 \mathrm{~V} \\ \mathrm{I}_{\mathrm{C}} & =50 \mathrm{~A} \\ \mathrm{R}_{\mathrm{G}} & =4.7 \Omega \\ \mathrm{~T}_{\mathrm{J}} & =+25^{\circ} \mathrm{C} \end{aligned}$ | - | 230 | - |  |
| $\mathrm{t}_{\mathrm{f}}$ | Current Fall Time |  | - | 26 | - |  |
| $\mathrm{E}_{\text {on1 }}$ | Turn-On Switching Energy ${ }^{(4)}$ |  | - | TBD | - | $\mu \mathrm{J}$ |
| $\mathrm{E}_{\text {on2 }}$ | Turn-On Switching Energy ${ }^{(5)}$ |  | - | 5330 | - |  |
| $\mathrm{E}_{\text {off }}$ | Turn-Off Switching Energy ${ }^{\left({ }^{( }\right)}$ |  | - | 2330 | - |  |
| $\mathrm{t}_{\mathrm{d}(\mathrm{O})}$ | Turn-On Delay Time | Inductive Switching $\left(125^{\circ} \mathrm{C}\right)$$V_{C C}=800 \mathrm{~V}$ | - | 24 | - | ns |
| $\mathrm{t}_{\mathrm{r}}$ | Current Rise Time |  | - | 53 | - |  |
| $\mathrm{t}_{\text {d(off) }}$ | Turn-Off Delay Time |  | - | 255 | - |  |
| $\mathrm{t}_{\mathrm{f}}$ | Current Fall Time | $\begin{gathered} \mathrm{V}_{\mathrm{GE}}=15 \mathrm{~V} \\ \mathrm{I}_{\mathrm{C}}=50 \mathrm{~A} \\ \mathrm{R}_{\mathrm{G}}=4.7 \Omega \\ \mathrm{~T}_{\mathrm{J}}=125^{\circ} \mathrm{C} \end{gathered}$ | - | 48 | - |  |
| $\mathrm{E}_{\text {on1 }}$ | Turn-On Switching Energy ${ }^{(4)}$ |  | - | TBD | - | $\mu \mathrm{J}$ |
| $\mathrm{E}_{\text {on2 }}$ | Turn-On Switching Energy ${ }^{\left({ }^{\text {a }} \text { ) }\right.}$ |  | - | 5670 | - |  |
| $\mathrm{E}_{\text {off }}$ | Turn-Off Switching Energy ${ }^{(6)}$ |  | - | 2850 | - |  |

Thermal and Mechanical Characteristics

| Symbol | Characteristic / Test Conditions | Min | Typ | Max | Unit |
| :---: | :--- | :---: | :---: | :---: | :---: |
| $\mathrm{R}_{\text {өлc }}$ | Junction to Case | - | - | 0.20 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $\mathrm{W}_{\mathrm{T}}$ | Package Weight | - | - | 5.9 | gm |

(1) Repetitive Rating: Pulse width limited by maximum junction temperature.
(2) For Combi devices, I ces includes both IGBT and FRED leakages
(3) See MIL-STD-750 Method 3471.
(4) $\mathrm{E}_{\text {on1 }}$ is the clamped inductive turn-on energy of the IGBT only, without the effect of a commutating diode reverse recovery current adding to the IGBT turn-on loss. Tested in inductive switching test circuit shown in figure 21, but with a Silicon Carbide diode.
(5) $\mathrm{E}_{\text {on2 }}$ is the clamped inductive turn-on energy that includes a commutating diode reverse recovery current in the IGBT turn-on switching loss. (See Figures 21, 22.)
(6) $\mathrm{E}_{\text {off }}$ is the clamped inductive turn-off energy measured in accordance with JEDEC standard JESD24-1. (See Figures 21, 23.)
(7) $\mathrm{R}_{\mathrm{G}}$ is external gate resistance not including gate driver impedance.

Microsemi reserves the right to change, without notice, the specifications and information contained herein.

Typical Performance Curves



FIGURE 3，Transfer Characteristics


FIGURE 5，On State Voltage vs Gate－to－Emitter Voltage


FIGURE 7，Threshold Voltage vs Junction Temperature

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FIGURE 2，Output Characteristics $\left(\mathrm{T}_{\mathrm{J}}=25^{\circ} \mathrm{C}\right)$


FIGURE 4，Gate charge


FIGURE 6，On State Voltage vs Junction Temperature


FIGURE 8，DC Collector Current vs Case Temperature

Typical Performance Curves



FIGURE 11, Current Rise Time vs Collector Current


FIGURE 13, Turn-On Energy Loss vs Collector Current


FIGURE 10, Turn-Off Delay Time vs Collector Current


FIGURE 12, Current Fall Time vs Collector Current


FIGURE 14, Turn-Off Energy Loss vs Collector Current


FIGURE 16, Switching Energy Losses vs Junction Temperature

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FIGURE 17, Capacitance vs Collector-To-Emitter Voltage
FIGURE 18, Minimum Switching Safe Operating Area


Figure 19a, Maximum Effective Transient Thermal Impedance, Junction-To-Case vs Pulse Duration


FIGURE 19b, TRANSIENT THERMAL IMPEDANCE MODEL


Figure 20, Operating Frequency vs Collector Current

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Figure 21, Inductive Switching Test Circuit


Figure 23, Turn-off Switching Waveforms and Definitions
T-MAX ${ }^{\circledR}$ Package Outline


Dimensions in Millimeters and (Inches)


Figure 22, Turn-on Switching Waveforms and Definitions

TO-264 Package Outline



[^0]:    萝念
    CAUTION：These Devices are Sensitive to Electrostatic Discharge．Proper Handling Procedures Should Be Followed．

